

February 2010

FDS4465 F085

P-Channel 1.8V Specified PowerTrench® MOSFET

General Description

This P-Channel 1.8V specified MOSFET is a rugged gate version of Fairchild Semiconductor's advanced PowerTrench process. It has been optimized for power management applications with a wide range of gate drive voltage (1.8V-8V).

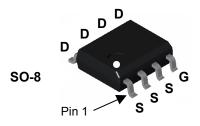
Applications

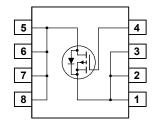
- · Power management
- · Load switch
- · Battery protection

Features

- -13.5 A, -20 V. $R_{DS(ON)}$ = 8.5 m Ω @ V_{GS} = -4.5 V $R_{DS(ON)}$ = 10.5 m Ω @ V_{GS} = -2.5 V $R_{DS(ON)}$ = 14 m Ω @ V_{GS} = -1.8 V
- · Fast switching speed
- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- High current and power handling capability
- Qualified to AEC Q101
- RoHS Compliant







Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		-20	V
V _{GSS}	Gate-Source Voltage		±8	V
I _D	Drain Current - Continuous	(Note 1a)	-13.5	A
	– Pulsed		-50	
P _D	Power Dissipation for Single Operation	(Note 1a)	2.5	W
		(Note 1b)	1.5	
		(Note 1c)	1.2	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +175	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	50	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient	(Note 1c)	125	°C/W
R _{θJC}	Thermal Resistance, Junction-to-Case	(Note 1)	25	°C/W

Package Marking and Ordering Information

	Device Marking	Device	Reel Size	Tape width	Quantity
_	FDS4465	FDS4465_F085	13"	12mm	2500 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
				- 7 P	1110121	0
	acteristics	_			ı	
BV _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-20			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, Referenced to 25°C		-12		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$			-1	μΑ
I_{GSSF}	Gate-Body Leakage, Forward	$V_{GS} = 8 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			100	nA
I_{GSSR}	Gate-Body Leakage, Reverse	$V_{GS} = -8 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-0.4	-0.6	-1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \mu\text{A}$, Referenced to 25°C		3		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -13.5 \text{ A}$ $V_{GS} = -2.5 \text{ V}, I_D = -12 \text{ A}$ $V_{GS} = -1.8 \text{ V}, I_D = -10.5 \text{ A}$ $V_{GS} = -4.5 \text{ V}, I_D = -13.5 \text{A}, T_J = 125 ^{\circ}\text{C}$		6.7 8.0 9.8 9.0	8.5 10.5 14 13	mΩ
I _{D(on)}	On-State Drain Current	$V_{GS} = -4.5 \text{ V}, V_{DS} = -5 \text{ V}$	-50			Α
g _{FS}	Forward Transconductance	$V_{DS} = -5 \text{ V}, \qquad I_{D} = -13.5 \text{ A}$		70		S
Dvnamio	Characteristics		•		•	•
C _{iss}	Input Capacitance	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$		8237		pF
Coss	Output Capacitance	f = 1.0 MHz		1497		pF
C _{rss}	Reverse Transfer Capacitance	1		750		pF
Switchir	ng Characteristics (Note 2)	•				
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -10V$, $I_{D} = -1$ A, $V_{GS} = -4.5 V$, $R_{GEN} = 6 \Omega$		20	36	ns
t _r	Turn-On Rise Time	$V_{GS} = -4.5 \text{ V}, \qquad R_{GEN} = 6 \Omega$		24	38	ns
t _{d(off)}	Turn-Off Delay Time	7		300	480	ns
t _f	Turn–Off Fall Time	7		140	224	ns
Qg	Total Gate Charge	$V_{DS} = -10 \text{ V}, \qquad I_{D} = -13.5 \text{ A},$		86	120	nC
Q _{gs}	Gate-Source Charge	V _{GS} = -4.5 V		20		nC
Q _{gd}	Gate-Drain Charge	7		11		nC
Drain-S	ource Diode Characteristics	and Maximum Ratings				
Is	Maximum Continuous Drain-Source				-2.1	Α
V _{SD}	Drain-Source Diode Forward	$V_{GS} = 0 \text{ V}, I_{S} = -2.1 \text{ A} \text{(Note 2)}$		-0.6	-1.2	V

Notes

1. R_{8JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{8JC} is guaranteed by design while R_{8CA} is determined by the user's board design.



a) 50 °C/W when mounted on a 1in² pad of 2 oz copper



b) 105 °C/W when mounted on a .04 in² pad of 2 oz copper



c) 125 °C/W when mounted on a minimum pad.

Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width < 300μs, Duty Cycle < 2.0%

Typical Characteristics

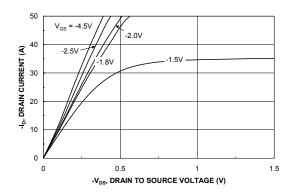


Figure 1. On-Region Characteristics.

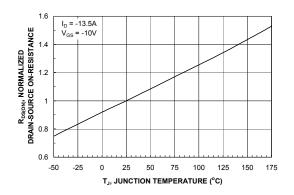


Figure 3. On-Resistance Variation with Temperature.

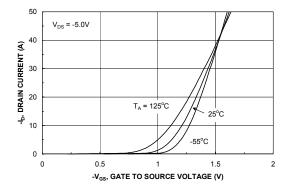


Figure 5. Transfer Characteristics.

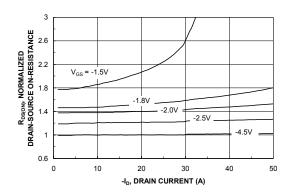


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

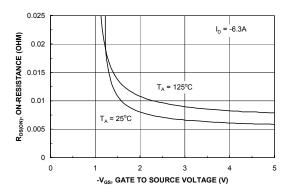


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

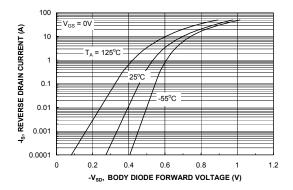
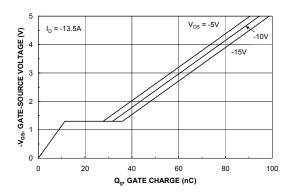


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



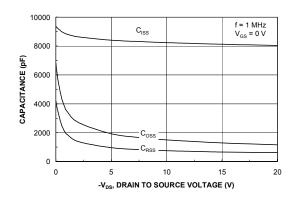
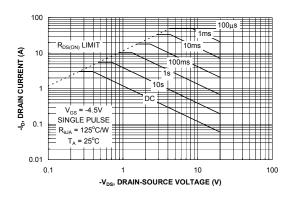


Figure 7. Gate Charge Characteristics.

Figure 8. Capacitance Characteristics.



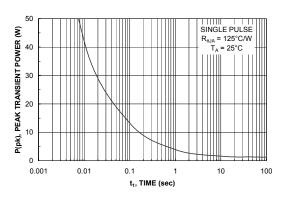


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

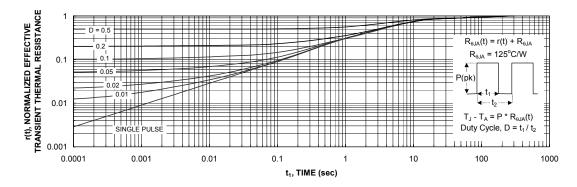


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

MOSFET

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